Search Notes

Application/Control No.	cation/Control No. Applicant(s)/Patent under Reexamination	
10/732,756	CHANG ET AL.	
Examiner	Art Unit	
DIANE D. MIZRAHI	2165	

SEARCHED					
Class	Subclass	Date	Examiner		
707	1-10, 100- 104.1; 200-206	6/22/2006	DM /I		
709	203,222,2		11		
718	100				
719	313				
707	120,136				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-			
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
INVENTOR SEARCH; 101/QAS PANEL; DOUBLE PATENTING;	6/22/2006	DM		
USPTO; USPG; EPO; JPO; DERWENT; IBM TECH; DERWENT; INTERNET; NPL; PERSONAL DIGESTS				
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